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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/525,499	09/21/2005	Valerie Bousquet	24500-000015/US	7512	
30593 7590 12/21/2007 HARNESS, DICKEY & PIERCE, P.L.C. P.O. BOX 8910			EXAMINER		
			SARKAR, ASOK K		
RESTON, VA	20195		ART UNIT	PAPER NUMBER	
			2891		
			MAIL DATE	DELIVERY MODE	
			12/21/2007	PAPER	

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

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		Application No.	Applicant(s)	V			
•		10/525,499	BOUSQUET ET AL.				
	Office Action Summary	Examiner	Art Unit				
		Asok K. Sarkar	2891				
Period fo	The MAILING DATE of this communication app or Reply	ears on the cover sheet with the	correspondence address				
A SHOWHIC - Exter after - If NO - Failu Any	ORTENED STATUTORY PERIOD FOR REPLY CHEVER IS LONGER, FROM THE MAILING DATE of time may be available under the provisions of 37 CFR 1.1 SIX (6) MONTHS from the mailing date of this communication. Period for reply is specified above, the maximum statutory period or te to reply within the set or extended period for reply will, by statute eply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be will apply and will expire SIX (6) MONTHS from the application to become ABANDON	DN. timely filed m the mailing date of this communication. NED (35 U.S.C. § 133).				
Status							
1)⊠	Responsive to communication(s) filed on 21 S	eptember 2005.					
	☐ This action is FINAL. 2b) ☐ This action is non-final.						
3)	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
	closed in accordance with the practice under E	Ex parte Quayle, 1935 C.D. 11,	453 O.G. 213.				
Disposit	ion of Claims						
4)⊠	Claim(s) 1-10 is/are pending in the application						
	4a) Of the above claim(s) is/are withdra	wn from consideration.					
, ——	Claim(s) is/are allowed.						
	6)⊠ Claim(s) <u>1-10</u> is/are rejected.						
	Claim(s) is/are objected to. Claim(s) are subject to restriction and/o	or election requirement.					
· 0)L	Claim(s) are subject to rectriction area.	,					
	ion Papers						
9)[The specification is objected to by the Examine	er.	to ditable the Evenine	•			
10)🖂	The drawing(s) filed on 23 February 2005 is/ar	e: a) 🖾 accepted or b) 🔝 object	cted to by the Examiner.				
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d). 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.							
		XXXIIII OI TOO WA GIIGAAA					
	under 35 U.S.C. § 119		() () ()				
	Acknowledgment is made of a claim for foreign	n priority under 35 U.S.C. § 119	(a)-(d) or (f).				
a	N⊠ All b) Some * c) None of:	to have been received					
 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 							
	3. Copies of the certified copies of the prior	ority documents have been rece	eived in this National Stage				
	application from the International Burea		-				
	See the attached detailed Office action for a lis		eived.				
Attachme	nt(s)						
1) Not	ice of References Cited (PTO-892)	4) Interview Summ					
2) Not	ice of Draftsperson's Patent Drawing Review (PTO-948) mation Disclosure Statement(s) (PTO/SB/08)	Paper No(s)/Ma 5) Notice of Inform					
3) 🔼 Info	imation Disclosure Statement(s) (P10/SB/08) ber No(s)/Mail Date <u>2/23/2005</u> .	6) Other:					

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DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. The factual inquiries set forth in *Graham* v. *John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:
 - 1. Determining the scope and contents of the prior art.
 - 2. Ascertaining the differences between the prior art and the claims at issue.
 - 3. Resolving the level of ordinary skill in the pertinent art.
 - 4. Considering objective evidence present in the application indicating obviousness or nonobviousness.
- 3. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).
- 4. Claims 1 10 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hatano, US 5,740,192.

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Regarding claim 1, Hatano teaches a method of growing a semiconductor layer structure, the method comprising the steps of:

- growing a first (Al,Ga)N layer over a substrate at the first substrate temperature
 by MBE using ammonia as the nitrogen precursor;
- cooling the substrate to a second substrate temperature lower than the first substrate temperature, while maintaining the supply of ammonia to the substrate;
- growing an (In,Ga)N quantum well structure over the first (A1,Ga)N layer using ammonia as the nitrogen precursor;
- heating the substrate to a third substrate temperature higher than the second substrate temperature, while maintaining the supply of ammonia to the substrate;
 and
- growing a second (A1,Ga)N layer over the quantum well structure at the third substrate temperature using ammonia as the nitrogen precursor mainly with reference to Example II 11(Fig. 14) in column 24 and also with reference to Examples II 9 (Fig. 12) and Example II 10 (Fig. 13) in columns 20 and 21 respectively.

Hatano teaches these limitations of growing the first and second layers of (AI,Ga)N and the (In,Ga)N layer by MOCVD process but <u>fails</u> to explicitly teach growing these layers by the MBE process.

Hatano, however, teaches growing these (Al,Ga)N and (In,Ga)N layers by the MBE process with reference to Example II – 4 and also with reference to Example II – 6

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wherein he teaches that MOCVD method can also be replaced by the MBE method in column 18, lines 21 – 27.

Therefore, it would have been obvious to one with ordinary skill in the art at the time of the invention to modify Hatano and grow the layers by MBE as taught by him in column 18, lines 21 - 27.

Regarding claims 2-4, Hatano teaches the first (A1,Ga)N layer has a first conductivity type of n – type and the second (A1,Ga)N layer has a second conductivity type of p – type with reference to Figs. 12, 13 and 14.

Regarding claims 5 – 7, Hatano teaches the first substrate temperature is within the range 850°C to 1050°C, the second substrate temperature is within the range 650°C to 1000°C and the third substrate temperature is within the range 850°C to 1050°C with reference to Example II – 11 in column 24 and MBE deposition temperatures with reference to Example II – 4 in column 13.

Regarding claims 8 - 10, Hatano teaches a light emitting diode with reference to Figs. 12, 13 and 14.

Conclusion

5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Asok K. Sarkar whose telephone number is 571 272 1970. The examiner can normally be reached on Monday - Friday (8 AM- 5 PM).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, William B. Baumeister can be reached on 571 272 1722. The fax phone

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number for the organization where this application or proceeding is assigned is 571-

273-8300.

6. Information regarding the status of an application may be obtained from the

Patent Application Information Retrieval (PAIR) system. Status information for

published applications may be obtained from either Private PAIR or Public PAIR.

Status information for unpublished applications is available through Private PAIR only.

For more information about the PAIR system, see http://pair-direct.uspto.gov. Should

you have questions on access to the Private PAIR system, contact the Electronic

Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a

USPTO Customer Service Representative or access to the automated information

system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Asok K. Sarkar

December 17, 2007

Primary examiner